

Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Product Summary

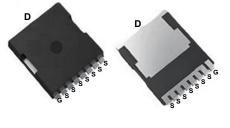


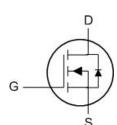
BVDSS	RDSON	ID
100V	$1.2 m\Omega$	350A

Applications

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

TOLL-8L Pin Configuration





■ Absolute Maximum Ratings (T_A=25°Cunless otherwise noted)

Parameter	Symbol	Value	Unit		
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain Current	T _C =25°C	L	350	А	
Continuous Diam Current	T _C =100°C	l _D	200		
Pulsed Drain Current ¹	Ірм	1248	А		
Single Pulse Avalanche Energy ²		EAS	1250	mJ	
Total Power Dissipation	T _C =25°C	P _D	390.6	W	
Operating Junction and Storage Temperature Range		TJ, TSTG	-55 to 150	°C	

Thermal Characteristics

Parameter	Symbol	Value	Unit	
Thermal Resistance from Junction-to-Ambient ³	R _{0JA}	39	°C/W	
Thermal Resistance from Junction-to-Case	Rелс	0.32	°C/W	



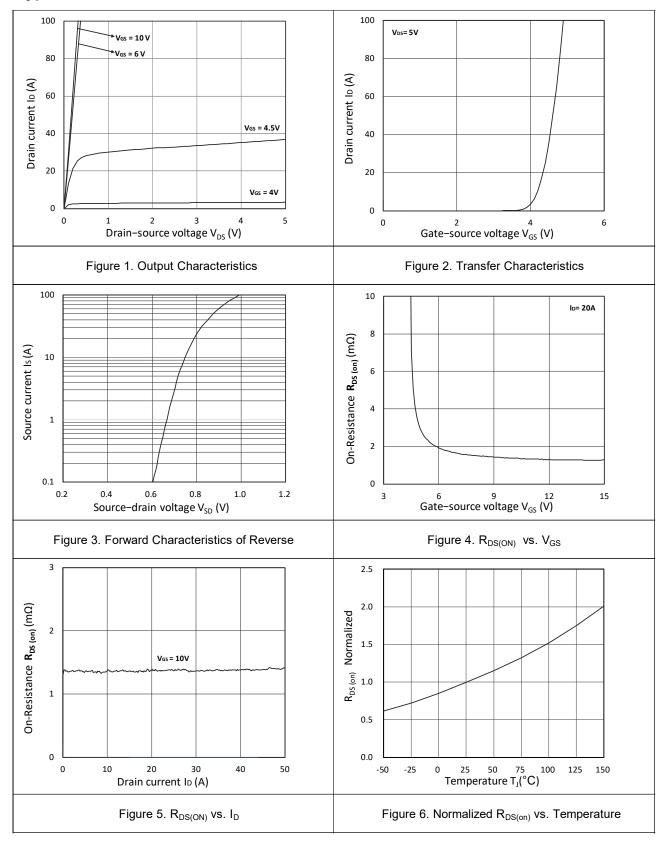
Electrical Characteristics ($T_J = 25$ °C, unless otherwise noted)

Parameter		Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static Characteristics				•			
Drain-Source Breakdown Vol	tage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	100	-	-	V
Gate-body Leakage current		Igss	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
Zero Gate Voltage Drain Current	T _J =25°C		1001/1/	-	-	1	•
	T _J =100°C	IDSS	V _{DS} = 100V, V _{GS} = 0V	-	-	100	μA
Gate-Threshold Voltage		V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
Drain-Source on-Resistance ⁴		R _{DS(on)}	V _{GS} = 10V, I _D = 20A	-	1.2	1.6	mΩ
Forward Transconductance ⁴		g fs	V _{DS} = 10V, I _D =20A	-	84	-	S
Dynamic Characteristics	5						
Input Capacitance		Ciss		-	14300	-	
Output Capacitance Reverse Transfer Capacitance		Coss	V _{DS} = 50V, V _{GS} =0V, f =1MHz	-	2120	-	pF
		Crss		-	50	-	
Gate Resistance		Rg	f=1MHz	-	2.8	-	Ω
Switching Characteristic	: s ⁵						
Total Gate Charge Gate-Source Charge Gate-Drain Charge		Qg		-	250	ı	nC
		Q _{gs}	$V_{GS} = 10V, V_{DS} = 50V,$ $I_{D} = 20A$	-	53	ı	
		Q _{gd}		-	77	ı	
Turn-on Delay Time		t _{d(on)}		-	41	-	
Rise Time Turn-off Delay Time Fall Time		t r	V _{GS} =10V, V _{DD} = 50V,	-	88	-	ns
		t _{d(off)}	$R_G = 3\Omega$, $I_D = 20A$	-	163	-	. 113
		t f		-	98	-	
Body Diode Reverse Recovery Time		t _{rr}	- I _F =20A, di/dt = 100A/μs	-	106	-	ns
Body Diode Reverse Recovery Charge		Qrr		-	245	-	nC
Drain-Source Body Diod	e Character	istics					
Diode Forward Voltage ⁴		Vsp	I _S = 20A, V _{GS} = 0V	-	-	1.2	V
Continuous Source Current	T _C =25°C	Is	-	-	-	350	Α

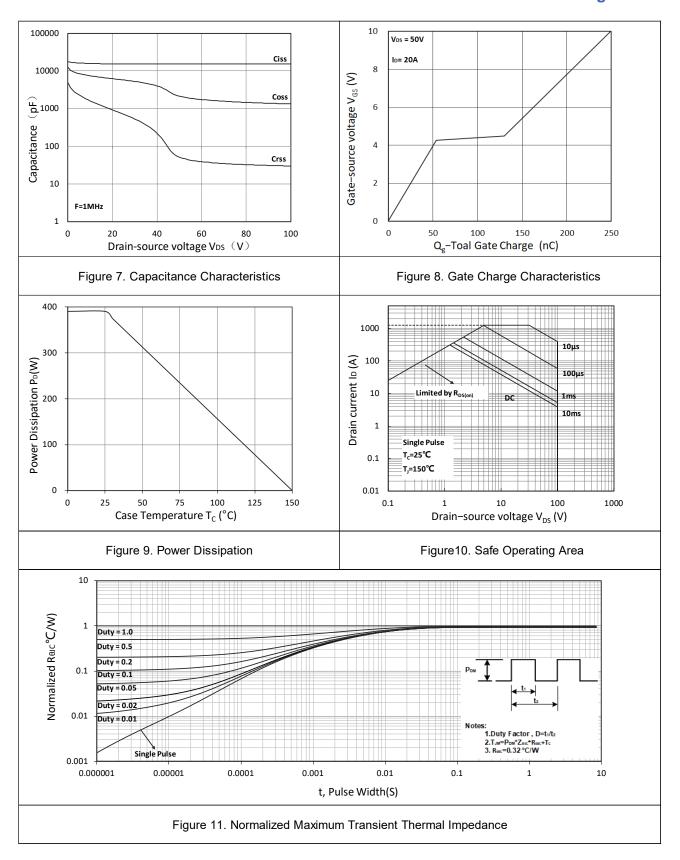
- The maximum current rating is package limited.
 Repetitive rating; pulse width limited by max. junction temperature.
- V_{DD} =32 V, R_G =25 Ω , L=0.5mH, starting T_j =25 $^{\circ}$ C.
- P_D is based on max. junction temperature, using junction-case thermal resistance.
- The value of R_{8JA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 ℃.



Typical Characteristics









Test Circuit

N-Ch 100V Fast Switching MOSFETs

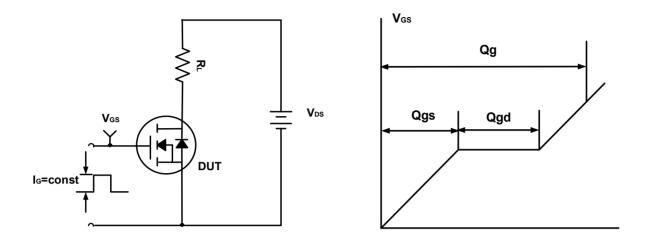


Figure A. Gate Charge Test Circuit & Waveforms

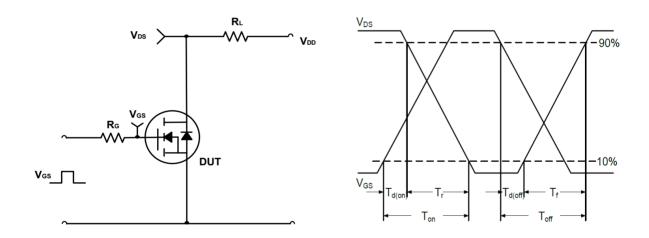


Figure B. Switching Test Circuit & Waveforms

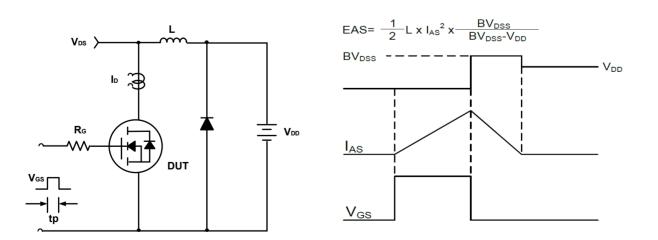
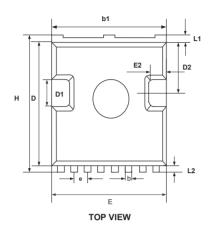
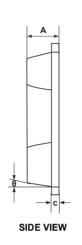


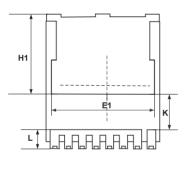
Figure C. Unclamped Inductive Switching Circuit & Waveforms



Mechanical Dimensions for TOLL-8L







BOTTTOM VIEW

COMMON DIMENSIONS

SYMBOL	MM			
	MIN	MAX		
А	2.20	2.40		
b	0.60	0.90		
b1	9.70	9.90		
С	0.40	0.60		
D	10.20	10.60		
D1	3.10	3.50		
D2	4.45	4.75		
E	9.70	10.10		
E1	7.80BSC			
E2	0.50	0.70		
е	1.200 BSC			
Н	11.45	11.90		
H1	6.75 BSC			
K	3.10 REF			
L	1.70	2.10		
L1	0.60	0.80		
L2	0.50	0.70		
θ	10° REF			